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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### **Details**

Product Status	Active
Number of LABs/CLBs	76500
Number of Logic Elements/Cells	979200
Total RAM Bits	55296000
Number of I/O	720
Number of Gates	-
Voltage - Supply	0.97V ~ 1.03V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	1924-BBGA, FCBGA
Supplier Device Package	1926-FCBGA (45x45)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7vx980t-1ffg1926i">https://www.e-xfl.com/product-detail/xilinx/xc7vx980t-1ffg1926i</a>

**Table 1: Absolute Maximum Ratings<sup>(1)</sup> (Cont'd)**

Symbol	Description	Min	Max	Units
$V_{MGTAVTTRCAL}$	Analog supply voltage for the resistor calibration circuit of the GTX/GTH transceiver column	-0.5	1.32	V
$V_{IN}$	Receiver (RXP/RXN) and Transmitter (TXP/TXN) absolute input voltage	-0.5	1.26	V
$I_{DCIN}$	DC input current for receiver input pins DC coupled $V_{MGTAVTT} = 1.2V$	-	14	mA
$I_{DCOUT}$	DC output current for transmitter pins DC coupled $V_{MGTAVTT} = 1.2V$	-	14	mA
<b>XADC</b>				
$V_{CCADC}$	XADC supply relative to GNDADC	-0.5	2.0	V
$V_{REFP}$	XADC reference input relative to GNDADC	-0.5	2.0	V
<b>Temperature</b>				
$T_{STG}$	Storage temperature (ambient)	-65	150	°C
$T_{SOL}$	Maximum soldering temperature for Pb/Sn component bodies <sup>(6)</sup>	-	+220	°C
	Maximum soldering temperature for Pb-free component bodies <sup>(6)</sup>	-	+260	°C
$T_j$	Maximum junction temperature <sup>(6)</sup>	-	+125	°C

**Notes:**

1. Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
2. The lower absolute voltage specification always applies.
3. For I/O operation, refer to the *7 Series FPGAs SelectIO Resources User Guide* ([UG471](#)).
4. The maximum limit applies to DC signals. For maximum undershoot and overshoot AC specifications, see [Table 4](#) and [Table 5](#).
5. See [Table 10](#) for TMD5\_33 specifications.
6. For soldering guidelines and thermal considerations, see the *7 Series FPGA Packaging and Pinout Specification* ([UG475](#)).

**Table 2: Recommended Operating Conditions<sup>(1)(2)</sup>**

Symbol	Description	Min	Typ	Max	Units
<b>FPGA Logic</b>					
$V_{CCINT}^{(3)}$	Internal supply voltage	0.97	1.00	1.03	V
	Internal supply voltage for -1C devices with voltage identification (VID) bit programmed to run at 0.9V typical <sup>(4)</sup> .	0.87	0.90	0.93	V
$V_{CCBRAM}^{(3)}$	Block RAM supply voltage	0.97	1.00	1.03	V
	Block RAM supply voltage for -1C devices with voltage identification (VID) bit programmed to run at 0.9V typical <sup>(4)</sup> .	0.87	0.90	1.03	V
$V_{CCAUX}$	Auxiliary supply voltage	1.71	1.80	1.89	V
$V_{CCO}^{(5)(6)}$	Supply voltage for 3.3V HR I/O banks	1.14	-	3.465	V
	Supply voltage for 1.8V HP I/O banks	1.14	-	1.89	V
$V_{CCAUX\_IO}$	Auxiliary supply voltage when set to 1.8V	1.71	1.80	1.89	V
	Auxiliary supply voltage when set to 2.0V	1.94	2.00	2.06	V
$V_{IN}^{(7)}$	I/O input voltage	-0.20	-	$V_{CCO} + 0.2$	V
	I/O input voltage (when $V_{CCO} = 3.3V$ ) for $V_{REF}$ and differential I/O standards except TMD5_33 <sup>(8)</sup>	-0.20	-	2.625	V
$I_{IN}^{(9)}$	Maximum current through any pin in a powered or unpowered bank when forward biasing the clamp diode.	-	-	10	mA
$V_{CCBATT}^{(10)}$	Battery voltage	1.0	-	1.89	V

**Table 3: DC Characteristics Over Recommended Operating Conditions (Cont'd)**

Symbol	Description	Min	Typ <sup>(1)</sup>	Max	Units
I <sub>RPD</sub>	Pad pull-down (when selected) @ V <sub>IN</sub> = 3.3V	68	–	330	μA
	Pad pull-down (when selected) @ V <sub>IN</sub> = 1.8V	45	–	180	μA
I <sub>CCADC</sub>	Analog supply current, analog circuits in powered up state	–	–	25	mA
I <sub>BATT</sub> <sup>(3)</sup>	Battery supply current	–	–	150	nA
R <sub>IN_TERM</sub> <sup>(4)</sup>	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_40) for commercial (C), industrial (I), and extended (E) temperature devices	28	40	55	Ω
	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_50) for commercial (C), industrial (I), and extended (E) temperature devices	35	50	65	Ω
	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_60) for commercial (C), industrial (I), and extended (E) temperature devices	44	60	83	Ω
n	Temperature diode ideality factor	–	1.010	–	–
r	Temperature diode series resistance	–	2	–	Ω

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. This measurement represents the die capacitance at the pad, not including the package.
3. Maximum value specified for worst case process at 25°C.
4. Termination resistance to a V<sub>CCO</sub>/2 level.

**Table 4: V<sub>IN</sub> Maximum Allowed AC Voltage Overshoot and Undershoot for 3.3V HR I/O Banks<sup>(1)</sup>**

AC Voltage Overshoot	% of UI @–40°C to 100°C	AC Voltage Undershoot	% of UI @–40°C to 100°C
V <sub>CCO</sub> + 0.55	100	–0.40	100
		–0.45	61.7
		–0.50	25.8
		–0.55	11.0
V <sub>CCO</sub> + 0.60	46.6	–0.60	4.77
V <sub>CCO</sub> + 0.65	21.2	–0.65	2.10
V <sub>CCO</sub> + 0.70	9.75	–0.70	0.94
V <sub>CCO</sub> + 0.75	4.55	–0.75	0.43
V <sub>CCO</sub> + 0.80	2.15	–0.80	0.20
V <sub>CCO</sub> + 0.85	1.02	–0.85	0.09
V <sub>CCO</sub> + 0.90	0.49	–0.90	0.04
V <sub>CCO</sub> + 0.95	0.24	–0.95	0.02

**Notes:**

1. A total of 200 mA per bank should not be exceeded.

**Table 6: Typical Quiescent Supply Current (Cont'd)**

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
I <sub>CCAUXQ</sub>	Quiescent V <sub>CCAUX</sub> supply current	XC7V585T	114	114	114	mA
		XC7V2000T	N/A	315	315	mA
		XC7VX330T	73	73	73	mA
		XC7VX415T	88	88	88	mA
		XC7VX485T	104	104	104	mA
		XC7VX550T	147	147	147	mA
		XC7VX690T	147	147	147	mA
		XC7VX980T	N/A	183	183	mA
		XC7VX1140T	N/A	250	250	mA
I <sub>CCAUX_IOQ</sub>	Quiescent V <sub>CCAUX_IO</sub> supply current	XC7V585T	2	2	2	mA
		XC7V2000T	N/A	2	2	mA
		XC7VX330T	2	2	2	mA
		XC7VX415T	2	2	2	mA
		XC7VX485T	2	2	2	mA
		XC7VX550T	2	2	2	mA
		XC7VX690T	2	2	2	mA
		XC7VX980T	N/A	2	2	mA
		XC7VX1140T	N/A	2	2	mA
I <sub>CCBRAMQ</sub>	Quiescent V <sub>CCBRAM</sub> supply current	XC7V585T	34	34	34	mA
		XC7V2000T	N/A	56	56	mA
		XC7VX330T	32	32	32	mA
		XC7VX415T	38	38	38	mA
		XC7VX485T	44	44	44	mA
		XC7VX550T	63	63	63	mA
		XC7VX690T	63	63	63	mA
		XC7VX980T	N/A	65	65	mA
		XC7VX1140T	N/A	81	81	mA

**Notes:**

1. Typical values are specified at nominal voltage, 85°C junction temperatures (T<sub>j</sub>) with single-ended SelectIO resources.
2. Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.
3. Use the Xilinx Power Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate static power consumption for conditions other than those specified.

## Power-On/Off Power Supply Sequencing

The recommended power-on sequence is  $V_{CCINT}$ ,  $V_{CCBRAM}$ ,  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  to achieve minimum current draw and ensure that the I/Os are 3-stated at power-on. The recommended power-off sequence is the reverse of the power-on sequence. If  $V_{CCINT}$  and  $V_{CCBRAM}$  have the same recommended voltage levels then both can be powered by the same supply and ramped simultaneously. If  $V_{CCAUX}$ ,  $V_{CCAUX\_IO}$ , and  $V_{CCO}$  have the same recommended voltage levels then they can be powered by the same supply and ramped simultaneously.

For  $V_{CCO}$  voltages of 3.3V in HR I/O banks and configuration bank 0:

- The voltage difference between  $V_{CCO}$  and  $V_{CCAUX}$  must not exceed 2.625V for longer than  $T_{VCCO2VCCAUX}$  for each power-on/off cycle to maintain device reliability levels.
- The  $T_{VCCO2VCCAUX}$  time can be allocated in any percentage between the power-on and power-off ramps.

The recommended power-on sequence to achieve minimum current draw for the GTX/GTH transceivers is  $V_{CCINT}$ ,  $V_{MGTAVCC}$ ,  $V_{MGTAVTT}$  OR  $V_{MGTAVCC}$ ,  $V_{CCINT}$ ,  $V_{MGTAVTT}$ . There is no recommended sequencing for  $V_{MGTVCCAUX}$ . Both  $V_{MGTAVCC}$  and  $V_{CCINT}$  can be ramped simultaneously. The recommended power-off sequence is the reverse of the power-on sequence to achieve minimum current draw.

If these recommended sequences are not met, current drawn from  $V_{MGTAVTT}$  can be higher than specifications during power-up and power-down.

- When  $V_{MGTAVTT}$  is powered before  $V_{MGTAVCC}$  and  $V_{MGTAVTT} - V_{MGTAVCC} > 150$  mV and  $V_{MGTAVCC} < 0.7$ V, the  $V_{MGTAVTT}$  current draw can increase by 460 mA per transceiver during  $V_{MGTAVCC}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{MGTAVCC}$  (ramp time from GND to 90% of  $V_{MGTAVCC}$ ). The reverse is true for power-down.
- When  $V_{MGTAVTT}$  is powered before  $V_{CCINT}$  and  $V_{MGTAVTT} - V_{CCINT} > 150$  mV and  $V_{CCINT} < 0.7$ V, the  $V_{MGTAVTT}$  current draw can increase by 50 mA per transceiver during  $V_{CCINT}$  ramp up. The duration of the current draw can be up to  $0.3 \times T_{VCCINT}$  (ramp time from GND to 90% of  $V_{CCINT}$ ). The reverse is true for power-down.

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Virtex-7 T and XT devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [AC Switching Characteristics, page 12](#). In each table, the I/O bank type is either High Performance (HP) or High Range (HR).

*Table 17: Networking Applications Interface Performances*

Description	I/O Bank Type	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	HR	710	710	625	Mb/s
	HP	710	710	625	Mb/s
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	HR	1250	1250	950	Mb/s
	HP	1600	1400	1250	Mb/s
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	HR	710	710	625	Mb/s
	HP	710	710	625	Mb/s
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	HR	1250	1250	950	Mb/s
	HP	1600	1400	1250	Mb/s

**Notes:**

1. LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

### IOB Pad Input/Output/3-State

Table 19 (3.3V high-range IOB (HR)) and Table 20 (1.8V high-performance IOB (HP)) summarizes the values of standard-specific data input delay adjustments, output delays terminating at pads (based on standard) and 3-state delays.

- $T_{IOPI}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.
- $T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.
- $T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer. In HP I/O banks, the internal DCI termination turn-on time is always faster than  $T_{IOTP}$  when the DCITERMDISABLE pin is used. In HR I/O banks, the IN\_TERM termination turn-on time is always faster than  $T_{IOTP}$  when the INTERMDISABLE pin is used.

Table 19: 3.3V IOB High Range (HR) Switching Characteristics

I/O Standard	$T_{IOPI}$			$T_{IOOP}$			$T_{IOTP}$			Units
	Speed Grade			Speed Grade			Speed Grade			
	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	
LVTTTL_S4	1.31	1.42	1.64	3.77	3.90	4.00	4.53	4.76	4.99	ns
LVTTTL_S8	1.31	1.42	1.64	3.50	3.64	3.73	4.26	4.50	4.72	ns
LVTTTL_S12	1.31	1.42	1.64	3.49	3.62	3.72	4.25	4.48	4.71	ns
LVTTTL_S16	1.31	1.42	1.64	3.03	3.17	3.26	3.79	4.03	4.25	ns
LVTTTL_S24	1.31	1.42	1.64	3.25	3.39	3.48	4.01	4.25	4.47	ns
LVTTTL_F4	1.31	1.42	1.64	3.22	3.36	3.45	3.98	4.22	4.44	ns
LVTTTL_F8	1.31	1.42	1.64	2.71	2.84	2.93	3.47	3.70	3.92	ns
LVTTTL_F12	1.31	1.42	1.64	2.69	2.82	2.92	3.45	3.68	3.91	ns
LVTTTL_F16	1.31	1.42	1.64	2.57	2.85	3.15	3.33	3.71	4.14	ns
LVTTTL_F24	1.31	1.42	1.64	2.41	2.64	2.89	3.17	3.50	3.88	ns
LVDS_25 <sup>(1)</sup>	0.64	0.68	0.80	1.36	1.47	1.55	2.12	2.33	2.54	ns
MINI_LVDS_25	0.68	0.70	0.79	1.36	1.47	1.55	2.12	2.33	2.54	ns
BLVDS_25 <sup>(1)</sup>	0.65	0.69	0.80	1.83	2.02	2.20	2.59	2.88	3.19	ns
RSDS_25 (point to point) <sup>(1)</sup>	0.63	0.68	0.79	1.36	1.48	1.55	2.12	2.34	2.54	ns
PPDS_25 <sup>(1)</sup>	0.65	0.69	0.80	1.36	1.49	1.58	2.12	2.35	2.57	ns
TMDS_33 <sup>(1)</sup>	0.72	0.76	0.86	1.43	1.54	1.60	2.19	2.40	2.59	ns
PCI33_3 <sup>(1)</sup>	1.28	1.41	1.65	2.71	3.08	3.52	3.47	3.94	4.51	ns
HSUL_12	0.63	0.64	0.71	1.77	1.90	2.00	2.53	2.76	2.99	ns
DIFF_HSUL_12	0.58	0.61	0.70	1.55	1.68	1.78	2.31	2.54	2.77	ns
HSTL_I_S	0.61	0.64	0.73	1.55	1.69	1.80	2.31	2.55	2.79	ns
HSTL_II_S	0.61	0.64	0.73	1.21	1.34	1.43	1.97	2.20	2.42	ns
HSTL_I_18_S	0.64	0.67	0.76	1.28	1.39	1.45	2.04	2.25	2.44	ns
HSTL_II_18_S	0.64	0.67	0.76	1.18	1.31	1.40	1.94	2.17	2.39	ns
DIFF_HSTL_I_S	0.63	0.67	0.77	1.42	1.54	1.61	2.18	2.40	2.60	ns
DIFF_HSTL_II_S	0.63	0.67	0.77	1.15	1.24	1.27	1.91	2.10	2.26	ns
DIFF_HSTL_I_18_S	0.65	0.69	0.78	1.27	1.38	1.43	2.03	2.24	2.42	ns
DIFF_HSTL_II_18_S	0.65	0.69	0.78	1.14	1.23	1.26	1.90	2.09	2.25	ns
HSTL_I_F	0.61	0.64	0.73	1.10	1.19	1.23	1.86	2.05	2.22	ns

**Table 19: 3.3V IOB High Range (HR) Switching Characteristics (Cont'd)**

I/O Standard	T <sub>IOP1</sub>			T <sub>IOP</sub>			T <sub>IOTP</sub>			Units
	Speed Grade			Speed Grade			Speed Grade			
	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	
HSTL_II_F	0.61	0.64	0.73	1.05	1.18	1.28	1.81	2.04	2.27	ns
HSTL_I_18_F	0.64	0.67	0.76	1.05	1.18	1.28	1.81	2.04	2.27	ns
HSTL_II_18_F	0.64	0.67	0.76	1.03	1.14	1.23	1.79	2.00	2.22	ns
DIFF_HSTL_I_F	0.63	0.67	0.77	1.09	1.18	1.22	1.85	2.04	2.21	ns
DIFF_HSTL_II_F	0.63	0.67	0.77	1.02	1.11	1.14	1.78	1.97	2.13	ns
DIFF_HSTL_I_18_F	0.65	0.69	0.78	1.08	1.17	1.21	1.84	2.03	2.20	ns
DIFF_HSTL_II_18_F	0.65	0.69	0.78	1.01	1.10	1.13	1.77	1.96	2.12	ns
LVC MOS33_S4	1.31	1.40	1.60	3.77	3.90	4.00	4.53	4.76	4.99	ns
LVC MOS33_S8	1.31	1.40	1.60	3.49	3.62	3.72	4.25	4.48	4.71	ns
LVC MOS33_S12	1.31	1.40	1.60	3.05	3.18	3.28	3.81	4.04	4.27	ns
LVC MOS33_S16	1.31	1.40	1.60	3.06	3.43	3.88	3.82	4.29	4.87	ns
LVC MOS33_F4	1.31	1.40	1.60	3.22	3.36	3.45	3.98	4.22	4.44	ns
LVC MOS33_F8	1.31	1.40	1.60	2.71	2.84	2.93	3.47	3.70	3.92	ns
LVC MOS33_F12	1.31	1.40	1.60	2.57	2.85	3.15	3.33	3.71	4.14	ns
LVC MOS33_F16	1.31	1.40	1.60	2.44	2.69	2.96	3.20	3.55	3.95	ns
LVC MOS25_S4	1.08	1.16	1.32	3.08	3.22	3.31	3.84	4.08	4.30	ns
LVC MOS25_S8	1.08	1.16	1.32	2.85	2.98	3.07	3.61	3.84	4.06	ns
LVC MOS25_S12	1.08	1.16	1.32	2.44	2.57	2.67	3.20	3.43	3.66	ns
LVC MOS25_S16	1.08	1.16	1.32	2.79	2.92	3.01	3.55	3.78	4.00	ns
LVC MOS25_F4	1.08	1.16	1.32	2.71	2.84	2.93	3.47	3.70	3.92	ns
LVC MOS25_F8	1.08	1.16	1.32	2.14	2.28	2.37	2.90	3.14	3.36	ns
LVC MOS25_F12	1.08	1.16	1.32	2.15	2.29	2.52	2.91	3.15	3.51	ns
LVC MOS25_F16	1.08	1.16	1.32	1.92	2.17	2.45	2.68	3.03	3.44	ns
LVC MOS18_S4	0.64	0.66	0.74	1.55	1.68	1.78	2.31	2.54	2.77	ns
LVC MOS18_S8	0.64	0.66	0.74	2.14	2.28	2.37	2.90	3.14	3.36	ns
LVC MOS18_S12	0.64	0.66	0.74	2.14	2.28	2.37	2.90	3.14	3.36	ns
LVC MOS18_S16	0.64	0.66	0.74	1.49	1.62	1.72	2.25	2.48	2.71	ns
LVC MOS18_S24 <sup>(1)</sup>	0.64	0.66	0.74	1.74	1.92	2.08	2.50	2.78	3.07	ns
LVC MOS18_F4	0.64	0.66	0.74	1.38	1.51	1.61	2.14	2.37	2.60	ns
LVC MOS18_F8	0.64	0.66	0.74	1.64	1.78	1.87	2.40	2.64	2.86	ns
LVC MOS18_F12	0.64	0.66	0.74	1.64	1.78	1.87	2.40	2.64	2.86	ns
LVC MOS18_F16	0.64	0.66	0.74	1.52	1.68	1.81	2.28	2.54	2.80	ns
LVC MOS18_F24 <sup>(1)</sup>	0.64	0.66	0.74	1.34	1.46	1.55	2.10	2.32	2.54	ns
LVC MOS15_S4	0.66	0.69	0.81	1.86	2.00	2.09	2.62	2.86	3.08	ns
LVC MOS15_S8	0.66	0.69	0.81	2.05	2.18	2.28	2.81	3.04	3.27	ns
LVC MOS15_S12	0.66	0.69	0.81	1.83	2.03	2.23	2.59	2.89	3.22	ns
LVC MOS15_S16	0.66	0.69	0.81	1.76	1.95	2.13	2.52	2.81	3.12	ns

**Table 20: 1.8V IOB High Performance (HP) Switching Characteristics (Cont'd)**

I/O Standard	T <sub>IOPI</sub>			T <sub>IOOP</sub>			T <sub>IOTP</sub>			Units
	Speed Grade			Speed Grade			Speed Grade			
	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	
LVDCI_15	0.59	0.62	0.73	1.98	2.23	2.58	2.62	2.99	3.40	ns
LVDCI_DV2_18	0.47	0.50	0.60	1.99	2.15	2.34	2.62	2.90	3.17	ns
LVDCI_DV2_15	0.59	0.62	0.73	1.98	2.23	2.58	2.62	2.99	3.40	ns
HSLVDCI_18	0.68	0.72	0.82	1.99	2.15	2.35	2.62	2.91	3.17	ns
HSLVDCI_15	0.68	0.72	0.82	1.98	2.23	2.58	2.62	2.99	3.40	ns
SSTL18_I_S	0.68	0.72	0.82	1.02	1.15	1.24	1.66	1.90	2.07	ns
SSTL18_II_S	0.68	0.72	0.82	1.17	1.29	1.37	1.81	2.05	2.19	ns
SSTL18_I_DCI_S	0.68	0.72	0.82	0.92	1.06	1.17	1.56	1.82	1.99	ns
SSTL18_II_DCI_S	0.68	0.72	0.82	0.88	0.98	1.08	1.51	1.74	1.90	ns
SSTL18_II_T_DCI_S	0.68	0.72	0.82	0.92	1.06	1.17	1.56	1.82	1.99	ns
SSTL15_S	0.68	0.72	0.82	0.94	1.06	1.15	1.58	1.82	1.97	ns
SSTL15_DCI_S	0.68	0.72	0.82	0.94	1.06	1.15	1.57	1.82	1.97	ns
SSTL15_T_DCI_S	0.68	0.72	0.82	0.94	1.06	1.15	1.57	1.82	1.97	ns
SSTL135_S	0.69	0.72	0.82	0.97	1.10	1.19	1.60	1.85	2.01	ns
SSTL135_DCI_S	0.69	0.72	0.82	0.97	1.09	1.19	1.60	1.85	2.01	ns
SSTL135_T_DCI_S	0.69	0.72	0.82	0.97	1.09	1.19	1.60	1.85	2.01	ns
SSTL12_S	0.69	0.72	0.82	0.96	1.09	1.18	1.60	1.84	2.00	ns
SSTL12_DCI_S	0.69	0.72	0.82	1.03	1.17	1.27	1.66	1.92	2.09	ns
SSTL12_T_DCI_S	0.69	0.72	0.82	1.03	1.17	1.27	1.66	1.92	2.09	ns
DIFF_SSTL18_I_S	0.75	0.79	0.92	1.02	1.15	1.24	1.66	1.90	2.07	ns
DIFF_SSTL18_II_S	0.75	0.79	0.92	1.17	1.29	1.37	1.81	2.05	2.19	ns
DIFF_SSTL18_I_DCI_S	0.75	0.79	0.92	0.92	1.06	1.17	1.56	1.82	1.99	ns
DIFF_SSTL18_II_DCI_S	0.75	0.79	0.92	0.88	0.98	1.08	1.51	1.74	1.90	ns
DIFF_SSTL18_II_T_DCI_S	0.75	0.79	0.92	0.92	1.06	1.17	1.56	1.82	1.99	ns
DIFF_SSTL15_S	0.68	0.72	0.82	0.94	1.06	1.15	1.58	1.82	1.97	ns
DIFF_SSTL15_DCI_S	0.68	0.72	0.82	0.94	1.06	1.15	1.57	1.82	1.97	ns
DIFF_SSTL15_T_DCI_S	0.68	0.72	0.82	0.94	1.06	1.15	1.57	1.82	1.97	ns
DIFF_SSTL135_S	0.69	0.72	0.82	0.97	1.10	1.19	1.60	1.85	2.01	ns
DIFF_SSTL135_DCI_S	0.69	0.72	0.82	0.97	1.09	1.19	1.60	1.85	2.01	ns
DIFF_SSTL135_T_DCI_S	0.69	0.72	0.82	0.97	1.09	1.19	1.60	1.85	2.01	ns
DIFF_SSTL12_S	0.69	0.72	0.82	0.96	1.09	1.18	1.60	1.84	2.00	ns
DIFF_SSTL12_DCI_S	0.69	0.72	0.82	1.03	1.17	1.27	1.66	1.92	2.09	ns
DIFF_SSTL12_T_DCI_S	0.69	0.72	0.82	1.03	1.17	1.27	1.66	1.92	2.09	ns
SSTL18_I_F	0.68	0.72	0.82	0.94	1.06	1.15	1.58	1.82	1.97	ns
SSTL18_II_F	0.68	0.72	0.82	0.97	1.09	1.16	1.61	1.84	1.99	ns
SSTL18_I_DCI_F	0.68	0.72	0.82	0.89	1.02	1.10	1.53	1.77	1.92	ns
SSTL18_II_DCI_F	0.68	0.72	0.82	0.89	1.02	1.10	1.53	1.77	1.92	ns
SSTL18_II_T_DCI_F	0.68	0.72	0.82	0.89	1.02	1.10	1.53	1.77	1.92	ns

Table 23: OLOGIC Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Setup/Hold</b>					
$T_{ODCK}/T_{OCKD}$	D1/D2 pins setup/hold with respect to CLK	0.45/-0.13	0.50/-0.13	0.58/-0.13	ns
$T_{OOCECK}/T_{OCKOCE}$	OCE pin setup/hold with respect to CLK	0.28/0.03	0.29/0.03	0.45/0.03	ns
$T_{OSRCK}/T_{OCKSR}$	SR pin setup/hold with respect to CLK	0.32/0.18	0.38/0.18	0.70/0.18	ns
$T_{OTCK}/T_{OCKT}$	T1/T2 pins setup/hold with respect to CLK	0.49/-0.16	0.56/-0.16	0.68/-0.16	ns
$T_{OTCECK}/T_{OCKTCE}$	TCE pin setup/hold with respect to CLK	0.28/0.01	0.30/0.01	0.45/0.01	ns
<b>Combinatorial</b>					
$T_{ODQ}$	D1 to OQ out or T1 to TQ out	0.73	0.81	0.97	ns
<b>Sequential Delays</b>					
$T_{OCKQ}$	CLK to OQ/TQ out	0.41	0.43	0.49	ns
$T_{RQ\_OLOGICE2}$	SR pin to OQ/TQ out (HP I/O banks only)	0.63	0.70	0.83	ns
$T_{GSRQ\_OLOGICE2}$	Global set/reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	ns
$T_{RQ\_OLOGICE3}$	SR pin to OQ/TQ out (HR I/O banks only)	0.63	0.70	0.83	ns
$T_{GSRQ\_OLOGICE3}$	Global set/reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	ns
<b>Set/Reset</b>					
$T_{RPW\_OLOGICE2}$	Minimum pulse width, SR inputs (HP I/O banks only)	0.54	0.54	0.63	ns, Min
$T_{RPW\_OLOGICE3}$	Minimum pulse width, SR inputs (HR I/O banks only)	0.54	0.54	0.63	ns, Min

## Output Serializer/Deserializer Switching Characteristics

Table 25: OSERDES Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Setup/Hold</b>					
$T_{OSDCK\_D}/T_{OSCKD\_D}$	D input setup/hold with respect to CLKDIV	0.37/0.02	0.40/0.02	0.55/0.02	ns
$T_{OSDCK\_T}/T_{OSCKD\_T}^{(1)}$	T input setup/hold with respect to CLK	0.49/-0.15	0.56/-0.15	0.68/-0.15	ns
$T_{OSDCK\_T2}/T_{OSCKD\_T2}^{(1)}$	T input setup/hold with respect to CLKDIV	0.27/-0.15	0.30/-0.15	0.34/-0.15	ns
$T_{OSCK\_OCE}/T_{OSCKC\_OCE}$	OCE input setup/hold with respect to CLK	0.28/0.03	0.29/0.03	0.45/0.03	ns
$T_{OSCK\_S}$	SR (Reset) input setup with respect to CLKDIV	0.41	0.46	0.75	ns
$T_{OSCK\_TCE}/T_{OSCKC\_TCE}$	TCE input setup/hold with respect to CLK	0.28/0.01	0.30/0.01	0.45/0.01	ns
<b>Sequential Delays</b>					
$T_{OSCKO\_OQ}$	Clock to out from CLK to OQ	0.35	0.37	0.42	ns
$T_{OSCKO\_TQ}$	Clock to out from CLK to TQ	0.41	0.43	0.49	ns
<b>Combinatorial</b>					
$T_{OSDO\_TQ}$	T input to TQ Out	0.73	0.81	0.97	ns

**Notes:**

- $T_{OSDCK\_T2}$  and  $T_{OSCKD\_T2}$  are reported as  $T_{OSDCK\_T}/T_{OSCKD\_T}$  in the timing report.

## CLB Switching Characteristics

Table 28: CLB Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Combinatorial Delays</b>					
$T_{ILO}$	An – Dn LUT address to A	0.05	0.05	0.06	ns, Max
$T_{ILO\_2}$	An – Dn LUT address to AMUX/CMUX	0.15	0.16	0.19	ns, Max
$T_{ILO\_3}$	An – Dn LUT address to BMUX_A	0.24	0.25	0.30	ns, Max
$T_{ITO}$	An – Dn inputs to A – D Q outputs	0.58	0.61	0.74	ns, Max
$T_{AXA}$	AX inputs to AMUX output	0.38	0.40	0.49	ns, Max
$T_{AXB}$	AX inputs to BMUX output	0.40	0.42	0.52	ns, Max
$T_{AXC}$	AX inputs to CMUX output	0.39	0.41	0.50	ns, Max
$T_{AXD}$	AX inputs to DMUX output	0.43	0.44	0.52	ns, Max
$T_{BxB}$	BX inputs to BMUX output	0.31	0.33	0.40	ns, Max
$T_{BxD}$	BX inputs to DMUX output	0.38	0.39	0.47	ns, Max
$T_{CxC}$	CX inputs to CMUX output	0.27	0.28	0.34	ns, Max
$T_{CxD}$	CX inputs to DMUX output	0.33	0.34	0.41	ns, Max
$T_{DxD}$	DX inputs to DMUX output	0.32	0.33	0.40	ns, Max
<b>Sequential Delays</b>					
$T_{CKO}$	Clock to AQ – DQ outputs	0.26	0.27	0.32	ns, Max
$T_{SHCKO}$	Clock to AMUX – DMUX outputs	0.32	0.32	0.39	ns, Max
<b>Setup and Hold Times of CLB Flip-Flops Before/After Clock CLK</b>					
$T_{AS}/T_{AH}$	$A_N – D_N$ input to CLK on A – D flip-flops	0.01/0.12	0.02/0.13	0.03/0.18	ns, Min
$T_{DICK}/T_{CKDI}$	$A_X – D_X$ input to CLK on A – D flip-flops	0.04/0.14	0.04/0.14	0.05/0.20	ns, Min
	$A_X – D_X$ input through MUXs and/or carry logic to CLK on A – D flip-flops	0.36/0.10	0.37/0.11	0.46/0.16	ns, Min
$T_{CECK\_CLB}/T_{CKCE\_CLB}$	CE input to CLK on A – D flip-flops	0.19/0.05	0.20/0.05	0.25/0.05	ns, Min
$T_{SRCK}/T_{CKSR}$	SR input to CLK on A – D flip-flops	0.30/0.05	0.31/0.07	0.37/0.09	ns, Min
<b>Set/Reset</b>					
$T_{SRMIN}$	SR input minimum pulse width	0.52	0.78	1.04	ns, Min
$T_{RQ}$	Delay from SR input to AQ – DQ flip-flops	0.38	0.38	0.46	ns, Max
$T_{CEO}$	Delay from CE input to AQ – DQ flip-flops	0.34	0.35	0.43	ns, Max
$F_{TOG}$	Toggle frequency (for export control)	1818	1818	1818	MHz

## Block RAM and FIFO Switching Characteristics

Table 31: Block RAM and FIFO Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Block RAM and FIFO Clock-to-Out Delays</b>					
T <sub>RCKO_DO</sub> and T <sub>RCKO_DO_REG</sub> <sup>(1)</sup>	Clock CLK to DOUT output (without output register) <sup>(2)(3)</sup>	1.57	1.80	2.08	ns, Max
	Clock CLK to DOUT output (with output register) <sup>(4)(5)</sup>	0.54	0.63	0.75	ns, Max
T <sub>RCKO_DO_ECC</sub> and T <sub>RCKO_DO_ECC_REG</sub>	Clock CLK to DOUT output with ECC (without output register) <sup>(2)(3)</sup>	2.35	2.58	3.26	ns, Max
	Clock CLK to DOUT output with ECC (with output register) <sup>(4)(5)</sup>	0.62	0.69	0.80	ns, Max
T <sub>RCKO_DO_CASCOUT</sub> and T <sub>RCKO_DO_CASCOUT_REG</sub>	Clock CLK to DOUT output with Cascade (without output register) <sup>(2)</sup>	2.21	2.45	2.80	ns, Max
	Clock CLK to DOUT output with Cascade (with output register) <sup>(4)</sup>	0.98	1.08	1.24	ns, Max
T <sub>RCKO_FLAGS</sub>	Clock CLK to FIFO flags outputs <sup>(6)</sup>	0.65	0.74	0.89	ns, Max
T <sub>RCKO_POINTERS</sub>	Clock CLK to FIFO pointers outputs <sup>(7)</sup>	0.79	0.87	0.98	ns, Max
T <sub>RCKO_PARITY_ECC</sub>	Clock CLK to ECCPARITY in ECC encode only mode	0.66	0.72	0.80	ns, Max
T <sub>RCKO_SDBIT_ECC</sub> and T <sub>RCKO_SDBIT_ECC_REG</sub>	Clock CLK to BITERR (without output register)	2.17	2.38	3.01	ns, Max
	Clock CLK to BITERR (with output register)	0.57	0.65	0.76	ns, Max
T <sub>RCKO_RDADDR_ECC</sub> and T <sub>RCKO_RDADDR_ECC_REG</sub>	Clock CLK to RDADDR output with ECC (without output register)	0.64	0.74	0.90	ns, Max
	Clock CLK to RDADDR output with ECC (with output register)	0.71	0.79	0.92	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>					
T <sub>RCKC_ADDRA</sub> /T <sub>RCKC_ADDRA</sub>	ADDR inputs <sup>(8)</sup>	0.38/0.27	0.42/0.28	0.48/0.31	ns, Min
T <sub>RDCK_DI_WF_NC</sub> / T <sub>RCKD_DI_WF_NC</sub>	Data input setup/hold time when block RAM is configured in WRITE_FIRST or NO_CHANGE mode <sup>(9)</sup>	0.49/0.51	0.55/0.53	0.63/0.57	ns, Min
T <sub>RDCK_DI_RF</sub> /T <sub>RCKD_DI_RF</sub>	Data input setup/hold time when block RAM is configured in READ_FIRST mode <sup>(9)</sup>	0.17/0.25	0.19/0.29	0.21/0.35	ns, Min
T <sub>RDCK_DI_ECC</sub> /T <sub>RCKD_DI_ECC</sub>	DIN inputs with block RAM ECC in standard mode <sup>(9)</sup>	0.42/0.37	0.47/0.39	0.53/0.43	ns, Min
T <sub>RDCK_DI_ECCW</sub> /T <sub>RCKD_DI_ECCW</sub>	DIN inputs with block RAM ECC encode only <sup>(9)</sup>	0.79/0.37	0.87/0.39	0.99/0.43	ns, Min
T <sub>RDCK_DI_ECC_FIFO</sub> / T <sub>RCKD_DI_ECC_FIFO</sub>	DIN inputs with FIFO ECC in standard mode <sup>(9)</sup>	0.89/0.47	0.98/0.50	1.12/0.54	ns, Min
T <sub>RCKC_INJECTBITERR</sub> / T <sub>RCKC_INJECTBITERR</sub>	Inject single/double bit error in ECC mode	0.49/0.30	0.55/0.31	0.63/0.34	ns, Min
T <sub>RCKC_EN</sub> /T <sub>RCKC_EN</sub>	Block RAM Enable (EN) input	0.30/0.17	0.33/0.18	0.38/0.20	ns, Min
T <sub>RCKC_REGCE</sub> /T <sub>RCKC_REGCE</sub>	CE input of output register	0.21/0.13	0.25/0.13	0.31/0.14	ns, Min
T <sub>RCKC_RSTREG</sub> /T <sub>RCKC_RSTREG</sub>	Synchronous RSTREG input	0.25/0.06	0.27/0.06	0.29/0.06	ns, Min
T <sub>RCKC_RSTRAM</sub> /T <sub>RCKC_RSTRAM</sub>	Synchronous RSTRAM input	0.27/0.35	0.29/0.37	0.31/0.39	ns, Min
T <sub>RCKC_WEA</sub> /T <sub>RCKC_WEA</sub>	Write Enable (WE) input (Block RAM only)	0.38/0.15	0.41/0.16	0.46/0.17	ns, Min
T <sub>RCKC_WREN</sub> /T <sub>RCKC_WREN</sub>	WREN FIFO inputs	0.39/0.25	0.39/0.30	0.40/0.37	ns, Min
T <sub>RCKC_RDEN</sub> /T <sub>RCKC_RDEN</sub>	RDEN FIFO inputs	0.36/0.26	0.36/0.30	0.37/0.37	ns, Min
<b>Reset Delays</b>					
T <sub>RCO_FLAGS</sub>	Reset RST to FIFO flags/pointers <sup>(10)</sup>	0.76	0.83	0.93	ns, Max
T <sub>RREC_RST</sub> /T <sub>RREM_RST</sub>	FIFO reset recovery and removal timing <sup>(11)</sup>	1.59/−0.68	1.76/−0.68	2.01/−0.68	ns, Max

## Clock Buffers and Networks

**Table 33: Global Clock Switching Characteristics (Including BUFGCTRL)**

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
$T_{BCCCK\_CE}/T_{BCCCK\_CE}^{(1)}$	CE pins setup/hold	0.12/0.30	0.14/0.38	0.26/0.38	ns
$T_{BCCCK\_S}/T_{BCCCK\_S}^{(1)}$	S pins setup/hold	0.12/0.30	0.14/0.38	0.26/0.38	ns
$T_{BCCCKO\_O}^{(2)}$	BUFGCTRL delay from I/O to O	0.08	0.10	0.12	ns
<b>Maximum Frequency</b>					
$F_{MAX\_BUFG}$	Global clock tree (BUFG)	741.00	710.00	625.00	MHz

**Notes:**

- $T_{BCCCK\_CE}$  and  $T_{BCCCK\_S}$  must be satisfied to assure glitch-free operation of the global clock when switching between clocks. These parameters do not apply to the BUFGMUX primitive that assures glitch-free operation. The other global clock setup and hold times are optional; only needing to be satisfied if device operation requires simulation matches on a cycle-for-cycle basis when switching between clocks.
- $T_{BCCCKO\_O}$  (BUFG delay from I/O to O) values are the same as  $T_{BCCCKO\_O}$  values.

**Table 34: Input/Output Clock Switching Characteristics (BUFIO)**

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
$T_{BIOCKO\_O}$	Clock to out delay from I to O	1.04	1.14	1.32	ns
<b>Maximum Frequency</b>					
$F_{MAX\_BUFIO}$	I/O clock tree (BUFIO)	800.00	800.00	710.00	MHz

**Table 35: Regional Clock Buffer Switching Characteristics (BUFR)**

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
$T_{BRCKO\_O}$	Clock to out delay from I to O	0.60	0.65	0.77	ns
$T_{BRCKO\_O\_BYP}$	Clock to out delay from I to O with Divide Bypass attribute set	0.30	0.32	0.38	ns
$T_{BRDO\_O}$	Propagation delay from CLR to O	0.71	0.75	0.96	ns
<b>Maximum Frequency</b>					
$F_{MAX\_BUFR}^{(1)}$	Regional clock tree (BUFR)	600.00	540.00	450.00	MHz

**Notes:**

- The maximum input frequency to the BUFR and BUFMR is the BUFIO  $F_{MAX}$  frequency.

**Table 36: Horizontal Clock Buffer Switching Characteristics (BUFH)**

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
$T_{BHCKO\_O}$	BUFH delay from I to O	0.10	0.11	0.13	ns
$T_{BHCKCK\_CE}/T_{BHCKCK\_CE}$	CE pin setup and hold	0.20/0.16	0.23/0.20	0.38/0.21	ns
<b>Maximum Frequency</b>					
$F_{MAX\_BUFH}$	Horizontal clock buffer (BUFH)	741.00	710.00	625.00	MHz

**Table 38: MMCM Specification (Cont'd)**

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
MMCM_T <sub>LOCKMAX</sub>	MMCM maximum Lock Time	100	100	100	μs
MMCM_F <sub>OUTMAX</sub>	MMCM maximum output frequency	1066.00	933.00	800.00	MHz
MMCM_F <sub>OUTMIN</sub>	MMCM minimum output frequency <sup>(5)(6)</sup>	4.69	4.69	4.69	MHz
MMCM_T <sub>EXTFDVAR</sub>	External clock feedback variation	< 20% of clock input period or 1 ns Max			
MMCM_RST <sub>MINPULSE</sub>	Minimum reset pulse width	5.00	5.00	5.00	ns
MMCM_F <sub>PFDMAX</sub>	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	MHz
MMCM_F <sub>PFDMIN</sub>	Minimum frequency at the phase frequency detector	10.00	10.00	10.00	MHz
MMCM_T <sub>FBDELAY</sub>	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle			
<b>MMCM Switching Characteristics Setup and Hold</b>					
T <sub>MMCMDCK_PSEN</sub> / T <sub>MMCMCKD_PSEN</sub>	Setup and hold of phase-shift enable	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMDCK_PSINCDEC</sub> / T <sub>MMCMCKD_PSINCDEC</sub>	Setup and hold of phase-shift increment/decrement	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMCKO_PSDONE</sub>	Phase shift clock-to-out of PSDONE	0.59	0.68	0.81	ns
<b>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</b>					
T <sub>MMCMDCK_DADDR</sub> / T <sub>MMCMCKD_DADDR</sub>	DADDR setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>MMCMDCK_DI</sub> /T <sub>MMCMCKD_DI</sub>	DI setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>MMCMDCK_DEN</sub> /T <sub>MMCMCKD_DEN</sub>	DEN setup/hold	1.76/0.00	1.97/0.00	2.29/0.00	ns, Min
T <sub>MMCMDCK_DWE</sub> /T <sub>MMCMCKD_DWE</sub>	DWE setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>MMCMCKO_DRDY</sub>	CLK to out of DRDY	0.65	0.72	0.99	ns, Max
F <sub>DCK</sub>	DCLK frequency	200.00	200.00	200.00	MHz, Max

**Notes:**

1. The MMCM does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
2. The static offset is measured between any MMCM outputs with identical phase.
3. Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
4. Includes global clock buffer.
5. Calculated as F<sub>VCO</sub>/128 assuming output duty cycle is 50%.
6. When CLKOUT4\_CASCADE = TRUE, MMCM\_F<sub>OUTMIN</sub> is 0.036 MHz.

## GTX Transceiver Specifications

### GTX Transceiver DC Input and Output Levels

Table 51 summarizes the DC specifications of the GTX transceivers in Virtex-7 T and XT FPGAs. Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide (UG476)* for further details.

Table 51: GTX Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to maximum setting	–	–	1000	mV
V <sub>CMOUTDC</sub>	DC common mode output voltage.	Equation based	$V_{MGTAVTT} - DV_{PPOUT}/4$			mV
R <sub>OUT</sub>	Differential output resistance		–	100	–	Ω
T <sub>OSKEW</sub>	Transmitter output pair (TXP and TXN) intra-pair skew		–	2	12	ps
DV <sub>PPIN</sub>	Differential peak-to-peak input voltage (external AC coupled)	>10.3125 Gb/s	150	–	1250	mV
		6.6 Gb/s to 10.3125 Gb/s	150	–	1250	mV
		≤ 6.6 Gb/s	150	–	2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled V <sub>MGTAVTT</sub> = 1.2V	–200	–	V <sub>MGTAVTT</sub>	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	2/3 V <sub>MGTAVTT</sub>	–	mV
R <sub>IN</sub>	Differential input resistance		–	100	–	Ω
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>		–	100	–	nF

**Notes:**

1. The output swing and preemphasis levels are programmable using the attributes discussed in the *7 Series FPGAs GTX/GTH Transceiver User Guide (UG476)*, and can result in values lower than reported in this table.
2. Other values can be used as appropriate to conform to specific protocols and standards.

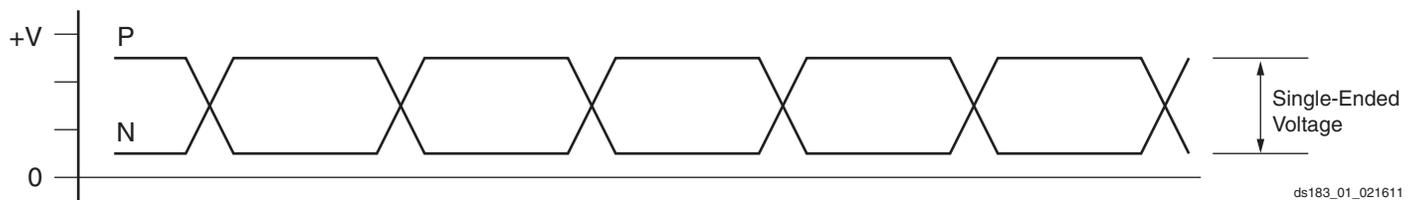


Figure 1: Single-Ended Peak-to-Peak Voltage

ds183\_01\_021611

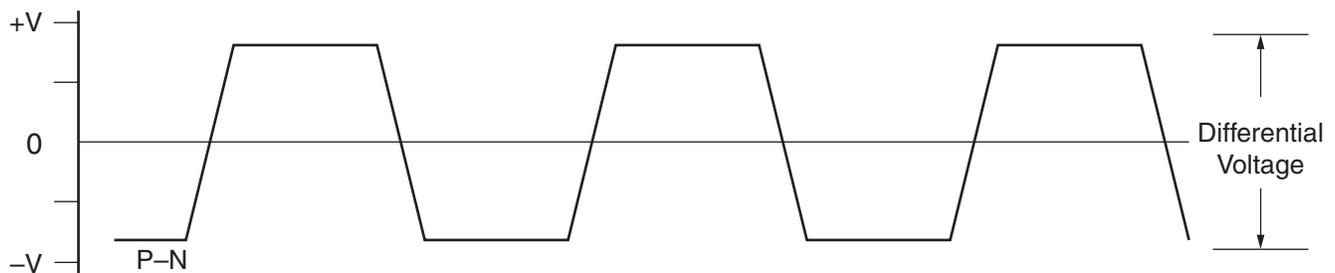


Figure 2: Differential Peak-to-Peak Voltage

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Table 52 summarizes the DC specifications of the clock input of the GTX transceiver. Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* (UG476) for further details.

Table 52: GTX Transceiver Clock DC Input Level Specification

Symbol	DC Parameter	Min	Typ	Max	Units
V <sub>IDIFF</sub>	Differential peak-to-peak input voltage	250	–	2000	mV
R <sub>IN</sub>	Differential input resistance	–	100	–	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor	–	100	–	nF

## GTX Transceiver Switching Characteristics

Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* (UG476) for further information.

Table 53: GTX Transceiver Performance

Symbol	Description	Output Divider	Speed Grade			Units
			-3/-2G	-2/-2L	-1 <sup>(1)</sup>	
F <sub>GTXMAX</sub> <sup>(2)</sup>	Maximum GTX transceiver data rate		12.5	10.3125	8.0	Gb/s
F <sub>GTXMIN</sub> <sup>(2)</sup>	Minimum GTX transceiver data rate		0.500	0.500	0.500	Gb/s
F <sub>GTXCRANGE</sub>	CPLL line rate range	1	3.2–6.6			Gb/s
		2	1.6–3.3			Gb/s
		4	0.8–1.65			Gb/s
		8	0.5–0.825			Gb/s
		16	N/A			Gb/s
F <sub>GTXQRANGE1</sub>	QPLL line rate range 1	1	5.93–8.0	5.93–8.0	5.93–8.0	Gb/s
		2	2.965–4.0	2.965–4.0	2.965–4.0	Gb/s
		4	1.4825–2.0	1.4825–2.0	1.4825–2.0	Gb/s
		8	0.74125–1.0	0.74125–1.0	0.74125–1.0	Gb/s
		16	N/A	N/A	N/A	Gb/s
F <sub>GTXQRANGE2</sub>	QPLL line rate range 2 <sup>(3)</sup>	1	9.8–12.5	9.8–10.3125	N/A	Gb/s
		2	4.9–6.25	4.9–5.15625	N/A	Gb/s
		4	2.45–3.125	2.45–2.578125	N/A	Gb/s
		8	1.225–1.5625	1.225–1.2890625	N/A	Gb/s
		16	0.6125–0.78125	0.6125–0.64453125	N/A	Gb/s
F <sub>GCPLL</sub> RANGE	GTX transceiver CPLL frequency range		1.6–3.3	1.6–3.3	1.6–3.3	GHz
F <sub>GQPLL</sub> RANGE1	GTX transceiver QPLL frequency range 1		5.93–8.0	5.93–8.0	5.93–8.0	GHz
F <sub>GQPLL</sub> RANGE2	GTX transceiver QPLL frequency range 2		9.8–12.5	9.8–10.3125	N/A	GHz

**Notes:**

- The -1 speed grade requires a 4-byte internal data width for operation above 5.0 Gb/s. A -1 speed grade with V<sub>CCINT</sub> = 0.9V, as described in the *Lowering Power using the Voltage Identification Bit* application note (XAPP555), requires a 4-byte internal data width for operation above 3.8 Gb/s.
- Data rates between 8.0 Gb/s and 9.8 Gb/s are not available.
- For QPLL line rate range 2, the maximum line rate with the divider N set to 66 is 10.3125Gb/s.

Table 54: GTX Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3/-2G	-2/-2L	-1	
F <sub>GTXDRPCLK</sub>	GTXDRPCLK maximum frequency	175.01	175.01	156.25	MHz

Table 59: GTX Transceiver Receiver Switching Characteristics

Symbol	Description		Min	Typ	Max	Units
F <sub>GTXRX</sub>	Serial data rate	RX oversampler not enabled	0.500	–	F <sub>GTXMAX</sub>	Gb/s
T <sub>RXELECIDLE</sub>	Time for RXELECIDLE to respond to loss or restoration of data		–	10	–	ns
RX <sub>OOBVDPP</sub>	OOB detect threshold peak-to-peak		60	–	150	mV
RX <sub>SST</sub>	Receiver spread-spectrum tracking <sup>(1)</sup>	Modulated @ 33 KHz	–5000	–	0	ppm
RX <sub>RL</sub>	Run length (CID)		–	–	512	UI
RX <sub>PPMTOL</sub>	Data/REFCLK PPM offset tolerance	Bit rates ≤ 6.6 Gb/s	–1250	–	1250	ppm
		Bit rates > 6.6 Gb/s and ≤ 8.0 Gb/s	–700	–	700	ppm
		Bit rates > 8.0 Gb/s	–200	–	200	ppm
<b>SJ Jitter Tolerance<sup>(2)</sup></b>						
JT_SJ <sub>12.5</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	12.5 Gb/s	0.3	–	–	UI
JT_SJ <sub>11.18</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	11.18 Gb/s	0.3	–	–	UI
JT_SJ <sub>10.32</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	10.32 Gb/s	0.3	–	–	UI
JT_SJ <sub>9.95</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	9.95 Gb/s	0.3	–	–	UI
JT_SJ <sub>9.8</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	9.8 Gb/s	0.3	–	–	UI
JT_SJ <sub>8.0</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	8.0 Gb/s	0.44	–	–	UI
JT_SJ <sub>6.6_QPLL</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	6.6 Gb/s	0.48	–	–	UI
JT_SJ <sub>6.6_CPLL</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	6.6 Gb/s	0.44	–	–	UI
JT_SJ <sub>5.0</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	5.0 Gb/s	0.44	–	–	UI
JT_SJ <sub>4.25</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	4.25 Gb/s	0.44	–	–	UI
JT_SJ <sub>3.75</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	3.75 Gb/s	0.44	–	–	UI
JT_SJ <sub>3.2</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	3.2 Gb/s <sup>(4)</sup>	0.45	–	–	UI
JT_SJ <sub>3.2L</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	3.2 Gb/s <sup>(5)</sup>	0.45	–	–	UI
JT_SJ <sub>2.5</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	2.5 Gb/s <sup>(6)</sup>	0.5	–	–	UI
JT_SJ <sub>1.25</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	1.25 Gb/s <sup>(7)</sup>	0.5	–	–	UI
JT_SJ <sub>500</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	500 Mb/s	0.4	–	–	UI
<b>SJ Jitter Tolerance with Stressed Eye<sup>(2)</sup></b>						
JT_TJSE <sub>3.2</sub>	Total jitter with stressed eye <sup>(8)</sup>	3.2 Gb/s	0.70	–	–	UI
JT_TJSE <sub>6.6</sub>		6.6 Gb/s	0.70	–	–	UI
JT_SJSE <sub>3.2</sub>	Sinusoidal jitter with stressed eye <sup>(8)</sup>	3.2 Gb/s	0.1	–	–	UI
JT_SJSE <sub>6.6</sub>		6.6 Gb/s	0.1	–	–	UI

**Notes:**

- Using RXOUT\_DIV = 1, 2, and 4.
- All jitter values are based on a bit error ratio of 1e<sup>-12</sup>.
- The frequency of the injected sinusoidal jitter is 80 MHz.
- CPLL frequency at 3.2 GHz and RXOUT\_DIV = 2.
- CPLL frequency at 1.6 GHz and RXOUT\_DIV = 1.
- CPLL frequency at 2.5 GHz and RXOUT\_DIV = 2.
- CPLL frequency at 2.5 GHz and RXOUT\_DIV = 4.
- Composite jitter with RX equalizer enabled. DFE disabled.

Table 67 summarizes the DC specifications of the clock input of the GTH transceiver. Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* (UG476) for further details.

Table 67: GTH Transceiver Clock DC Input Level Specification

Symbol	DC Parameter	Min	Typ	Max	Units
V <sub>IDIFF</sub>	Differential peak-to-peak input voltage	350	–	2000	mV
R <sub>IN</sub>	Differential input resistance	–	100	–	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor	–	100	–	nF

## GTH Transceiver Switching Characteristics

Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* (UG476) for further information.

Table 68: GTH Transceiver Performance

Symbol	Description	Output Divider	Speed Grade			Units
			-3E/-2GE	-2(C&I)/-2LE	-1(C&I) <sup>(1)</sup>	
F <sub>GTHMAX</sub>	Maximum GTH transceiver data rate		13.1	11.3	8.5	Gb/s
F <sub>GTHMIN</sub>	Minimum GTH transceiver data rate		0.500	0.500	0.500	Gb/s
F <sub>GTHCRANGE</sub>	CPLL line rate range	1	3.2–10.3125		3.2–8.0	Gb/s
		2	1.6–5.16		1.6–4.0	Gb/s
		4	0.8–2.58		0.8–2.0	Gb/s
		8	0.5–1.29		0.5–1.0	Gb/s
		16	N/A			Gb/s
F <sub>GTHQRANGE1</sub>	QPLL line rate range 1	1	8.0–11.85	8.0–11.3	8.0–8.5	Gb/s
		2	4.0–5.925	4.0–5.65	4.0–4.25	Gb/s
		4	2.0–2.9625	2.0–2.825	2.0–2.125	Gb/s
		8	1.0–1.48125	1.0–1.4125	1.0–1.0625	Gb/s
		16	N/A			Gb/s
F <sub>GTHQRANGE2</sub>	QPLL line rate range 2	1	11.85–13.1	N/A		Gb/s
		2	5.925–6.55	N/A		Gb/s
		4	2.96–3.275	N/A		Gb/s
		8	1.48–1.63	N/A		Gb/s
		16	0.74–0.81	N/A		Gb/s
F <sub>GCPLL</sub> RANGE	GTH transceiver CPLL frequency range		1.6–5.16		1.6–4.0	GHz
F <sub>GQPLL</sub> RANGE1	GTH transceiver QPLL frequency range 1		8.0–11.85	8.0–11.3	8.0–8.5	GHz
F <sub>GQPLL</sub> RANGE2	GTH transceiver QPLL frequency range 2		11.85–13.1	N/A		GHz

**Notes:**

- The -1 speed grade requires a 4-byte internal data width for operation above 5.0 Gb/s. A -1 speed grade with V<sub>CCINT</sub> = 0.9V, as described in the *Lowering Power using the Voltage Identification Bit* application note (XAPP555), requires a 4-byte internal data width for operation above 3.8 Gb/s.

Table 69: GTH Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3/-2G	-2L	-2	-1	
F <sub>GTHDRPCLK</sub>	GTHDRPCLK maximum frequency	175	175	175	156	MHz

**Table 73: GTH Transceiver Transmitter Switching Characteristics (Cont'd)**

Symbol	Description	Condition	Min	Typ	Max	Units
TJ <sub>8.0_CPLL</sub>	Total jitter <sup>(3)(4)</sup>	8.0 Gb/s	–	–	0.32	UI
DJ <sub>8.0_CPLL</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.17	UI
TJ <sub>6.6_QPLL</sub>	Total jitter <sup>(2)(4)</sup>	6.6 Gb/s	–	–	0.28	UI
DJ <sub>6.6_QPLL</sub>	Deterministic jitter <sup>(2)(4)</sup>		–	–	0.17	UI
TJ <sub>6.6_CPLL</sub>	Total jitter <sup>(3)(4)</sup>	6.6 Gb/s	–	–	0.30	UI
DJ <sub>6.6_CPLL</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>5.0</sub>	Total jitter <sup>(3)(4)</sup>	5.0 Gb/s	–	–	0.30	UI
DJ <sub>5.0</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>4.25</sub>	Total jitter <sup>(3)(4)</sup>	4.25 Gb/s	–	–	0.30	UI
DJ <sub>4.25</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>3.75</sub>	Total jitter <sup>(3)(4)</sup>	3.75 Gb/s	–	–	0.30	UI
DJ <sub>3.75</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.15	UI
TJ <sub>3.20</sub>	Total jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(5)</sup>	–	–	0.2	UI
DJ <sub>3.20</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.1	UI
TJ <sub>3.20L</sub>	Total jitter <sup>(3)(4)</sup>	3.20 Gb/s <sup>(6)</sup>	–	–	0.32	UI
DJ <sub>3.20L</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.16	UI
TJ <sub>2.5</sub>	Total jitter <sup>(3)(4)</sup>	2.5 Gb/s <sup>(7)</sup>	–	–	0.20	UI
DJ <sub>2.5</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.08	UI
TJ <sub>1.25</sub>	Total jitter <sup>(3)(4)</sup>	1.25 Gb/s <sup>(8)</sup>	–	–	0.15	UI
DJ <sub>1.25</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.06	UI
TJ <sub>500</sub>	Total jitter <sup>(3)(4)</sup>	500 Mb/s	–	–	0.1	UI
DJ <sub>500</sub>	Deterministic jitter <sup>(3)(4)</sup>		–	–	0.03	UI

**Notes:**

- Using same REFCLK input with TX phase alignment enabled for up to 12 consecutive transmitters (three fully populated GTH Quads).
- Using QPLL\_FBDIV = 40, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
- Using CPLL\_FBDIV = 2, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
- All jitter values are based on a bit-error ratio of  $1e^{-12}$ .
- CPLL frequency at 3.2 GHz and TXOUT\_DIV = 2.
- CPLL frequency at 1.6 GHz and TXOUT\_DIV = 1.
- CPLL frequency at 2.5 GHz and TXOUT\_DIV = 2.
- CPLL frequency at 2.5 GHz and TXOUT\_DIV = 4.

Date	Version	Description
03/27/2013	1.13	In <a href="#">Table 7</a> , added values for the XC7VX330T and XC7VX415T devices. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX330T and XC7VX415T. In <a href="#">Table 18</a> , updated the table title, LPDDR2 values, and removed Note 3. Removed Note 2: <i>For QPLL line rate, the maximum line rate with the divider N set to 66 is 10.3125 Gb/s</i> from <a href="#">Table 68</a> .
04/17/2013	1.14	Updated the <a href="#">AC Switching Characteristics</a> section with production release changes to <a href="#">Table 15</a> and <a href="#">Table 16</a> for XC7VX550T for all speed specifications. In <a href="#">Table 1</a> , revised $V_{IN}$ (I/O input voltage) to match values in <a href="#">Table 4</a> and <a href="#">Table 5</a> , and combined <a href="#">Note 4</a> with old <a href="#">Note 5</a> and then added new <a href="#">Note 5</a> . Revised $V_{IN}$ description and added <a href="#">Note 8</a> in <a href="#">Table 2</a> . Updated first 3 rows in <a href="#">Table 4</a> and <a href="#">Table 5</a> . Updated values and added new values to <a href="#">Table 7</a> . Also revised PCI33_3 voltage minimum in <a href="#">Table 10</a> to match values in <a href="#">Table 1</a> , <a href="#">Table 4</a> , and <a href="#">Table 5</a> . Added <a href="#">Note 1</a> to <a href="#">Table 12</a> and <a href="#">Table 13</a> . Throughout the data sheet ( <a href="#">Table 29</a> , <a href="#">Table 30</a> , and <a href="#">Table 45</a> ) removed the obvious note "A Zero "0" Hold Time listing indicates no hold time or a negative hold time." Updated and clarified USRCLK data in <a href="#">Table 57</a> and <a href="#">Table 72</a> .

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